

**Search Notes**

Application/Control No.

10/037,443

Examiner

David E. Bochna

Applicant(s)/Patent under  
Reexamination

TEUSCHER ET AL.

Art Unit

3679

**SEARCHED**

Class	Subclass	Date	Examiner
285	134.1	5/28/2006	DB
	135.4		
	276		
	278		
	281		
	280		
	275		
128	207.14		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
285	134.1	5/28/2006	DB
	280		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR